Section 1: General

- 1.1 This standard provides procedures for low-voltage wet sponge testing and high-voltage spark testing of new coatings on conductive substrates.
- 1.2 Electrical testing to determine the presence and number of discontinuities in a coating is performed on a nonconductive coating applied to a conductive substrate. The allowable number of discontinuities should be determined prior to conducting this test, because the acceptable number of discontinuities varies depending on coating thickness, design, and service conditions.
- 1.3 This standard is not intended to provide data on service life, adhesion, or film thickness of an applied coating system. Electrical testing does not detect areas where the coating is thin (even as thin as 25 µm [1.0 mil]).
- 1.4 This standard is intended for use only with new coatings applied to conductive substrates. Inspecting a coating previously exposed to an immersion condition could result in damage to the coating or could produce an erroneous detection of discontinuities due to permeation or moisture absorption of the coating. Deposits may also be

The use of a high-voltage spark tester on previously exposed coatings can result in a spark that damages an otherwise sound coating. A low-voltage wet sponge tester may be used without damaging the coating but can produce erroneous readings.

- 1.5 To prevent damage to a coating if a high-voltage spark tester is being used, the total film thickness and dielectric strength of the coating system shall be considered in selecting the appropriate voltage for detection of discontinuities.
- 1.6 The coating manufacturer shall be consulted to obtain the following information, which can affect the accuracy of the tests described in this standard to determine discontinuities:
- (a) The length of time required to adequately dry or cure the applied coating prior to testing. Solvents retained in an uncured coating may form an electrical conductive path through the film to the substr
- cating contains electrically conductive (b) Whether ents that may affect the normal dielectric

Coating: A liquid, liquefiable, or mastic composition that, after application to a surface, is converted into a solid protective, decorative, or functional adherent film.

Discontinuity: (1) An interrupt:

tructure or configurations and include the surface of t Definitions

seams, inclusions, or porosity. A discontinuity may or may not affect the usefulness of the coating. (2) A condition in which the electrical path of a structure is interrupted by a device that acts as a dielectric or insulated fitting. May also be identified as a holiday or pinhole.

A discontinuity in a protective coating that exposes unprotected surface to the environment; in this standard, a term used interchangeably with discontinuity.

Holiday Detector: A device that locates discontinuities in a coating applied to a conductive substrate.

Pinhole: A minute hole through a coat or coats that exposes an underlying coat or the substrate.

Telegraphing: Current that travels through a moisture patch to a discontinuity, causing an erroneous discontinuity test result.

Section 3: Low-Voltage Wet Sponge Testing

3.1 Equipment

3.1.1 A low-voltage wet sponge tester is an electronic device powered by a self-contained battery with voltages ranging from 5 to 90 V direct current (DC), depending on the manufacturer's circuit design. It is used to locate discontinuities in a nonconductive coating applied to a conductive substrate. Operation

includes the use of an open-cell sponge electrode saturated with a solution for exploring the coating surface, a ground connection, and an audible or visual indicator for signaling a point of coating discontinuity.

3.1.2 The operating voltage of a low-voltage wet sponge tester is a function of the particular electronic

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